1. General description

Planar Maximum Efficiency General Application (MEGA) Schottky barrier rectifier with an integrated guard ring for stress protection, encapsulated in a CFP15 (SOT1289) power and flat lead Surface-Mounted Device (SMD) plastic package.

2. Features and benefits

- Average forward current: I_{F(AV)} ≤ 3 A
- Reverse voltage: V_R ≤ 50 V
- · Extremely low forward voltage
- · High power capability due to clip-bonding technology and heat sink
- · Small and thin SMD power plastic package, typical height 0.78 mm
- AEC-Q101 qualified

3. Applications

- · Low voltage rectification
- High efficiency DC-to-DC conversion
- Switch mode power supply
- Freewheeling application
- Reverse polarity protection
- Low power consumption application

4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
I _{F(AV)}	average forward current	square wave; δ = 0.5 ; f = 20 kHz; T _{sp} ≤ 165 °C		-	-	3	А
V_R	reverse voltage	T _j = 25 °C		-	-	50	V
V _F	forward voltage	$I_F = 3 \text{ A}; t_p \le 300 \mu\text{s}; \delta \le 0.02 ;$ $T_j = 25 ^{\circ}\text{C}$		-	460	530	mV
I _R	reverse current	V _R = 10 V; T _j = 25 °C; pulsed	[1]	-	5	30	μA
		V_R = 50 V; T_j = 25 °C; pulsed	[1]	-	35	100	μΑ

[1] Very short test pulse to prevent junction self heating



5. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	Α	anode		ν D A
2	Α	anode		A aaa-009063
3	K	cathode	2 CFP15 (SOT1289)	244 00000

6. Ordering information

Table 3. Ordering information

Type number	Package	ge				
	Name	Description	Version			
PMEG050V030EPD	CFP15	plastic, thermal enhanced ultra thin SMD package; 3 leads; body: 5.8 x 4.3 x 0.78 mm	SOT1289			

7. Marking

Table 4. Marking codes

Type number	Marking code
PMEG050V030EPD	050V U03E

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
V _R	reverse voltage	T _j = 25 °C		-	50	V
IF	forward current	$T_{sp} \le 163 ^{\circ}\text{C}; \delta = 1$		-	4.2	Α
I _{F(AV)}	average forward current	square wave; δ = 0.5 ; f = 20 kHz; $T_{sp} \le$ 165 °C		-	3	Α
I _{FSM}	non-repetitive peak forward current	square wave; t_p = 8 ms; $T_{j(init)}$ = 25 °C		-	120	А
P _{tot}	total power dissipation	T _{amb} ≤ 25 °C	[1]	-	1.66	W
			[2]	-	2.15	W
Tj	junction temperature			-	175	°C
T _{amb}	ambient temperature			-55	175	°C
T _{stg}	storage temperature			-65	175	°C

^[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

9. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
uig-a)	thermal resistance from junction to ambient	in free air	[1][2]	-	-	90	K/W
			[1][3]	_	_	70	K/W
R _{th(j-sp)}	thermal resistance from junction to solder point		[4]	-	-	3	K/W

^[1] For Schottky barrier diodes thermal runaway has to be considered, as in some applications the reverse power losses P_R are a significant part of the total power losses.

^[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for cathode 1 cm².

^[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

^[3] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for cathode 1 cm².

^[4] Soldering point of cathode tab.

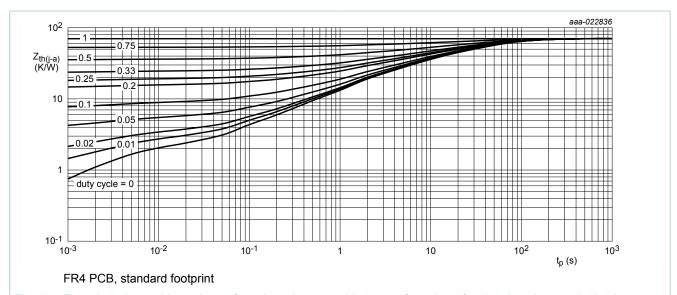


Fig. 1. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

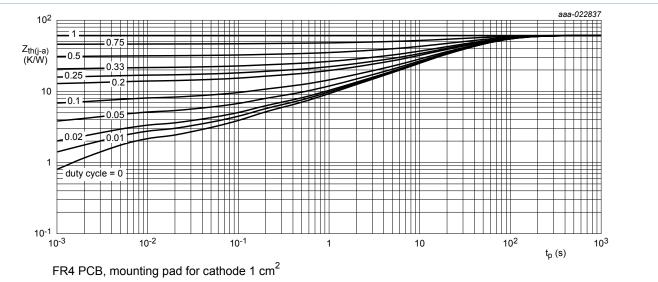


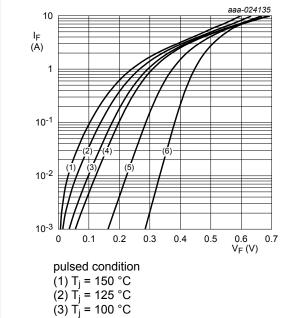
Fig. 2. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

10. Characteristics

Table 7. Characteristics

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
$V_{(BR)R}$	reverse breakdown voltage	I_R = 3 mA; T_j = 25 °C; pulsed	[1]	50	-	-	V
V _F	forward voltage	$I_F = 0.1 \text{ A; } t_p \le 300 \mu\text{s; } \delta \le 0.02 \text{ ; } T_j = 25 \text{ °C}$		-	285	330	mV
		I_F = 1 A; $t_p \le 300 \ \mu s$; $\delta \le 0.02$; T_j = 25 °C		-	375	440	mV
		I_F = 1.5 A; $t_p \le 300 \mu s$; δ ≤ 0.02 ; T_j = 25 °C		-	400	470	mV
		I_F = 2 A; $t_p \le 300 \ \mu s$; $\delta \le 0.02$; T_j = 25 °C		-	420	500	mV
		I_F = 3 A; $t_p \le 300 \ \mu s$; $\delta \le 0.02$; T_j = 25 °C		-	460	530	mV
		I_F = 3 A; $t_p \le 300 \ \mu s$; $\delta \le 0.02$; T_j = -40 °C		-	505	-	mV
		I_F = 3 A; $t_p \le 300 \ \mu s$; δ ≤ 0.02 ; T_j = 125 °C		-	400	-	mV
I _R	reverse current	V _R = 5 V; T _j = 25 °C; pulsed	[1]	-	4	15	μΑ
		V _R = 10 V; T _j = 25 °C; pulsed	[1]	-	5	30	μΑ
		V _R = 50 V; T _j = 25 °C; pulsed	[1]	-	35	100	μΑ
		V _R = 50 V; T _j = 125 °C; pulsed	[1]	-	20	-	mA
C _d	diode capacitance	V _R = 1 V; f = 1 MHz; T _j = 25 °C		-	350	-	pF
		V _R = 4 V; f = 1 MHz; T _j = 25 °C		-	195	-	pF
		V _R = 10 V; f = 1 MHz; T _j = 25 °C		-	120	-	pF
t _{rr}	reverse recovery time step recovery	$I_F = 0.5 \text{ A}; I_R = 0.5 \text{ A}; I_{R(meas)} = 0.1 \text{ A};$ $T_j = 25 ^{\circ}\text{C}$		-	12	-	ns
	reverse recovery time ramp recovery	$dI_F/dt = 200 \text{ A/}\mu\text{s}; T_j = 25 \text{ °C}; I_F = 6 \text{ A}; V_R = 26 \text{ V}$		-	11	-	ns

^[1] Very short test pulse to prevent junction self heating



$$(4) T_j = 85 ^{\circ}C$$

$$(5) T_j = 25 ^{\circ}C$$

$$(6) T_j = -40 ^{\circ}C$$

Fig. 3. Forward current as a function of forward voltage; typical values

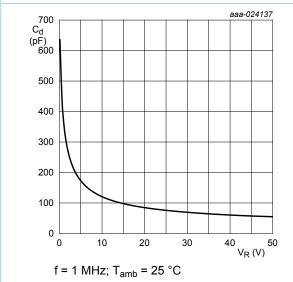


Fig. 5. Diode capacitance as a function of reverse voltage; typical values

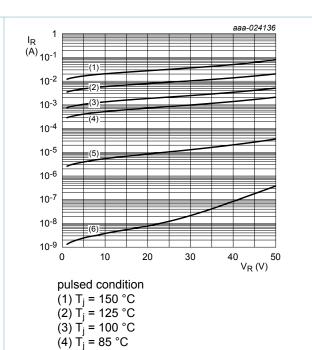
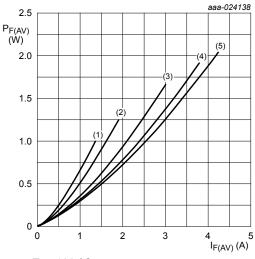


Fig. 4. Reverse current as a function of reverse voltage; typical values

(5) $T_j = 25 ^{\circ}C$ (6) $T_j = -40 ^{\circ}C$



 $T_j = 100 \, ^{\circ}C$

 $(1) \delta = 0.1$

(2) $\delta = 0.2$

 $(3) \delta = 0.5$ $(4) \delta = 0.8$

 $(5) \delta = 1$

Fig. 6. Average forward power dissipation as a function of average forward current; typical values

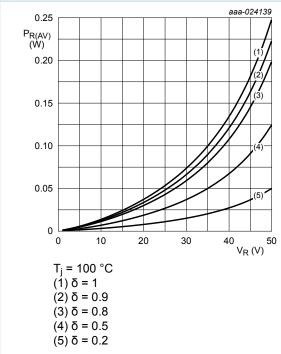
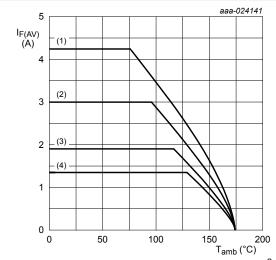


Fig. 7. Average reverse power dissipation as a function of reverse voltage; typical values



FR4 PCB, mounting pad for cathode 1 cm²

 $T_j = 175 \,{}^{\circ}\text{C}$

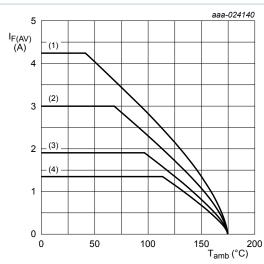
 $(1) \delta = 1; DC$

(2) δ = 0.5; f = 20 kHz

(3) δ = 0.2; f = 20 kHz

(4) δ = 0.1; f = 20 kHz

Fig. 9. Average forward current as a function of ambient temperature; typical values



FR4 PCB, standard footprint

T_i = 175 °C

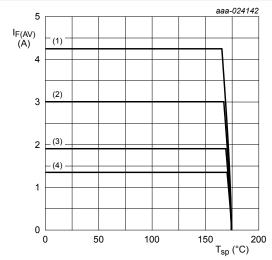
 $(1) \delta = 1; DC$

(2) $\delta = 0.5$; f = 20 kHz

(3) $\delta = 0.2$; f = 20 kHz

(4) $\delta = 0.1$; f = 20 kHz

Fig. 8. Average forward current as a function of ambient temperature; typical values



 $T_i = 175 \,{}^{\circ}\text{C}$

 $(1) \delta = 1; DC$

(2) δ = 0.5; f = 20 kHz

(3) δ = 0.2; f = 20 kHz

(4) δ = 0.1; f = 20 kHz

Fig. 10. Average forward current as a function of solder point temperature; typical values

11. Test information

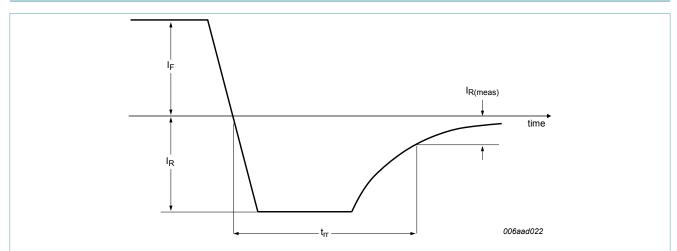


Fig. 11. Reverse recovery definition; step recovery

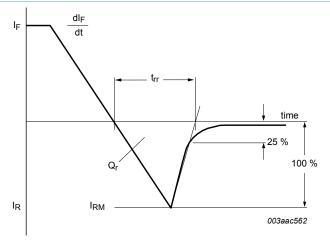


Fig. 12. Reverse recovery definition; ramp recovery

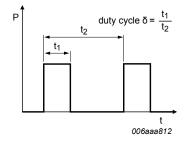


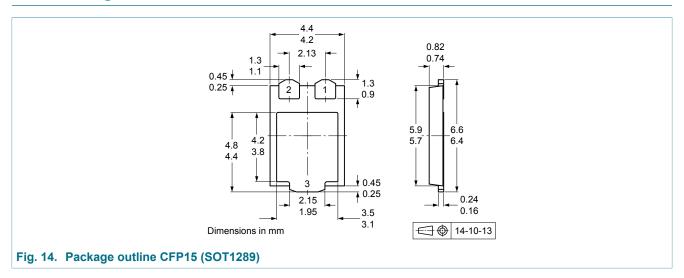
Fig. 13. Duty cycle definition

The current ratings for the typical waveforms are calculated according to the equations: $I_{F(AV)} = I_M \times \delta$ with I_M defined as peak current, $I_{RMS} = I_{F(AV)}$ at DC, and $I_{RMS} = I_M \times \sqrt{\delta}$ with I_{RMS} defined as RMS current.

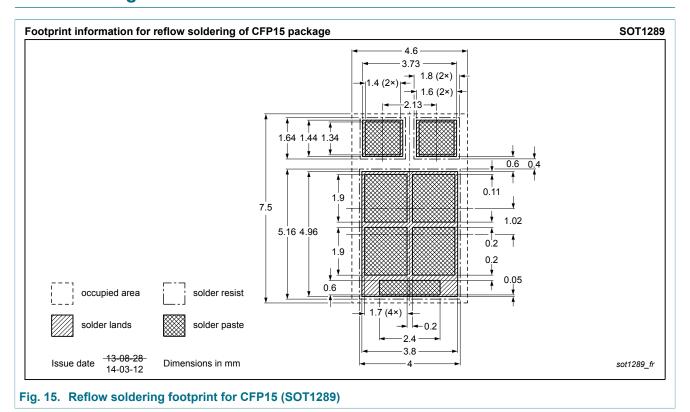
Quality information

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard Q101 - Stress test qualification for discrete semiconductors, and is suitable for use in automotive applications.

12. Package outline



13. Soldering



14. Revision history

Table 8. Revision history

Data sheet ID	Release date	Data sheet status	Change notice	Supersedes
PMEG050V030EPD v.1	20160812	Product data sheet	-	-

15. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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